

L Number	Hits	Search Text	DB	Time stamp
1	0	5760445.pn. and degradation	USPAT; US-PGPUB	2003/08/06 14:08
2	1	5760445.pn. and characteristics	USPAT; US-PGPUB	2003/08/06 14:13
3	1	high adj energy adj implant adj devices	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/08/06 14:15
4	0	high adj energy adj implant adj structures	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/08/06 14:16
5	499	high adj energy adj implant	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/08/06 14:16
6	393	(high adj energy adj implant) and 257/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/08/06 14:17